



STB11NB40 STB11NB40-1

N-CHANNEL 400V - 0.48 Ω - 10.7A D²PAK/I²PAK
PowerMESH™ MOSFET

Table 1. General Features

Type	V _{DSS}	R _{D(on)}	I _D
STB11NB40	400 V	< 0.55 Ω	10.7 A
STB11NB40-1	400 V	< 0.55 Ω	10.7 A

FEATURES SUMMARY

- TYPICAL R_{D(on)} = 0.48 Ω
- EXTREMELY HIGH dv/dt CAPABILITY
- 100% AVALANCHE TESTED
- VERY LOW INTRINSIC CAPACITANCES
- GATE CHARGE MINIMIZED

DESCRIPTION

Using the latest high voltage MESH OVERLAY™ process, STMicroelectronics has designed an advanced family of power MOSFETs with outstanding performances. The new patent pending strip layout coupled with the Company's proprietary edge termination structure, gives the lowest R_{D(on)} per area, exceptional avalanche and dv/dt capabilities and unrivalled gate charge and switching characteristics.

APPLICATIONS

- HIGH CURRENT, HIGH SPEED SWITCHING
- SWITCH MODE POWER SUPPLIES (SMPS)
- DC-AC CONVERTERS FOR WELDING EQUIPMENT AND UNINTERRUPTIBLE POWER SUPPLIES AND MOTOR DRIVE

Figure 1. Package

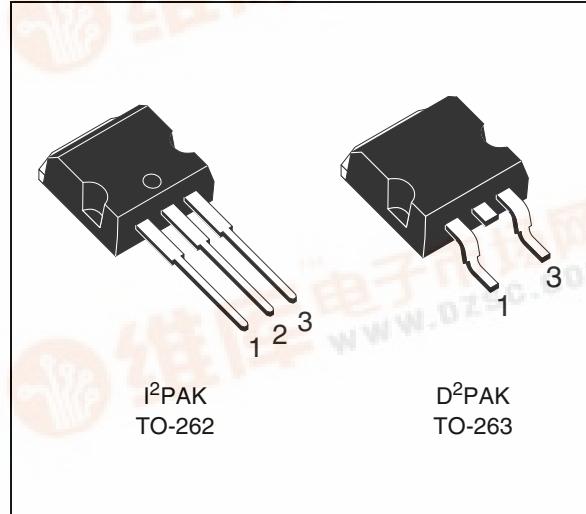


Figure 2. Internal Schematic Diagram

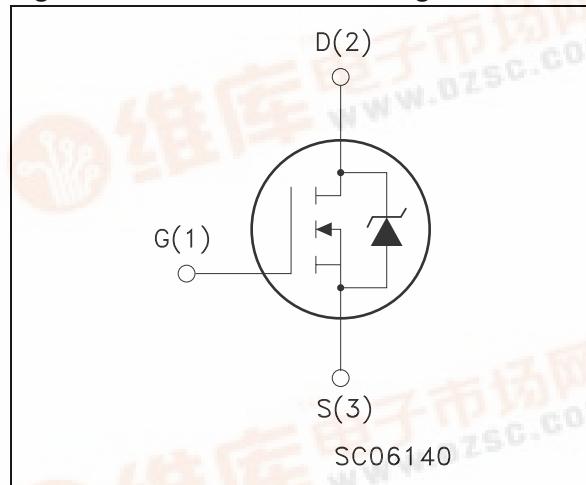


Table 2. Order Codes

Part Number	Marking	Package	Packaging
STB11NB40T4	B11NB40	D ² PAK	TAPE & REEL
STB11NB40-1	B11NB40	I ² PAK	TUBE

STB11NB40/STB11NB40-1

Table 3. Absolute Maximum Ratings

Symbol	Parameter	Value	Unit
V_{DS}	Drain-source Voltage ($V_{GS} = 0$)	400	V
V_{DGR}	Drain-gate Voltage ($R_{GS} = 20 \text{ k}\Omega$)	400	V
V_{GS}	Gate-source Voltage	± 30	V
I_D	Drain Current (cont.) at $T_C = 25^\circ\text{C}$	10.7	A
I_D	Drain Current (cont.) at $T_C = 100^\circ\text{C}$	6.7	A
$I_{DM}^{(1)}$	Drain Current (pulsed)	42.8	A
P_{tot}	Total Dissipation at $T_C = 25^\circ\text{C}$	125	W
	Derating Factor	1.0	W/C
$dv/dt^{(2)}$	Storage Temperature	4.5	V/ns
T_{stg}	Storage Temperature	-65 to 150	$^\circ\text{C}$
T_j	Max. Operating Junction Temperature	150	$^\circ\text{C}$

Note: 1. Pulse width limited by safe operating area
 2. $I_{SD} \leq 11\text{A}$, $di/dt \leq 200 \text{ A}/\mu\text{s}$, $V_{DD} \leq V_{(BR)DSS}$, $T_j \leq T_{JMAX}$

Table 4. Thermal Data

Symbol	Parameter	Value	Unit
$R_{thj-case}$	Thermal Resistance Junction-case Max	1.0	$^\circ\text{C/W}$
$R_{thj-amb}$	Thermal Resistance Junction-ambient Max	62.5	$^\circ\text{C/W}$
T_I	Maximum Lead Temperature For Soldering Purpose	300	$^\circ\text{C}$

Table 5. Avalanche Characteristics

Symbol	Parameter	Max Value	Unit
I_{AR}	Avalanche Current, Repetitive or Not-Repetitive (pulse width limited by T_j max, $\delta < 1\%$)	10.7	A
E_{AS}	Single Pulse Avalanche Energy (starting $T_j = 25^\circ\text{C}$; $I_D = I_{AR}$; $V_{DD} = 50 \text{ V}$)	530	mJ

ELECTRICAL CHARACTERISTICS ($T_{case} = 25^\circ C$ unless otherwise specified)

Table 6. Off

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
$V_{(BR)DSS}$	Drain-source Breakdown Voltage	$I_D = 250 \mu A; V_{GS} = 0$	400			V
I_{DSS}	Zero Gate Voltage Drain Current ($V_{GS} = 0$)	$V_{DS} = \text{Max Rating}$ $V_{DS} = \text{Max Rating } T_c = 125^\circ C$			1 50	μA μA
I_{GSS}	Gate-body Leakage Current ($V_{DS} = 0$)	$V_{GS} = \pm 30 V$			± 100	nA

Table 7. On (1)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}; I_D = 250 \mu A$	3	4	5	V
$R_{DS(on)}$	Static Drain-source On Resistance	$V_{GS} = 10V; I_D = 5.3 A$		0.48	0.55	Ω

Note: 1. Pulsed: Pulse duration = 300 μs , duty cycle 1.5 %

Table 8. Dynamic

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
$g_{fs}^{(1)}$	Forward Transconductance	$V_{DS} > I_{D(on)} \times R_{DS(on)\max}; I_D = 5.3 A$	5	6.5		S
C_{iss}	Input Capacitance	$V_{DS} = 25 V; f = 1 MHz; V_{GS} = 0$		1115	1450	pF
C_{oss}	Output Capacitance			210	280	pF
C_{rss}	Reverse Transfer Capacitance			22	30	pF

Note: 1. Pulsed: Pulse duration = 300 μs , duty cycle 1.5 %

Table 9. Switching On

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
$t_{d(on)}$	Turn-on Time	$V_{DD} = 200 V; I_D = 5.3 A; R_G = 4.7 \Omega$		17	25	ns
t_r	Rise Time	$V_{GS} = 10 V$ (see test circuit, Figure 16)		10	15	ns
Q_g	Total Gate Charge	$V_{DD} = 320 V; I_D = 10.7 A; V_{GS} = 10 V$		29.5	43	nC
Q_{gs}	Gate-Source Charge			10.6		nC
Q_{gd}	Gate-Drain Charge			11.8		nC

Table 10. Switching Off

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
$t_{r(Voff)}$	Off-voltage Rise Time	$V_{DD} = 320 V; I_D = 10.7 A; R_G = 4.7 \Omega$		10	14	ns
t_f	Fall Time	$V_{GS} = 10 V$ (see test circuit, Figure 18)		10	14	ns
t_c	Cross-over Time			17	25	ns

STB11NB40/STB11NB40-1

Table 11. Source Drain Diode

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
I_{SD}	Source-drain Current				10.7	A
$I_{SDM}^{(1)}$	Source-drain Current (pulsed)				42.8	A
$V_{SD}^{(2)}$	Forward On Voltage	$I_{SD} = 10.7 \text{ A}; V_{GS} = 0$			1.6	V
t_{rr}	Reverse Recovery Time	$I_{SD} = 10.7 \text{ A}; di/dt = 100 \text{ A}/\mu\text{s}$		400		ns
Q_{rr}	Reverse Recovery Charge	$V_{DD} = 100 \text{ V}; T_j = 150^\circ\text{C}$ (see test circuit, Figure 18)		3.4		μC
I_{RRAM}	Reverse Recovery Charge			17		A

Note: 1. Pulse width limited by safe operating area
2. Pulsed: Pulse duration = 300 μs , duty cycle 1.5 %

Figure 3. Safe Operating Area

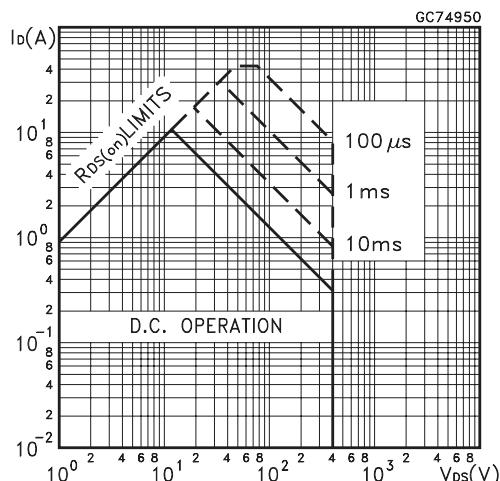


Figure 4. Thermal Impedance

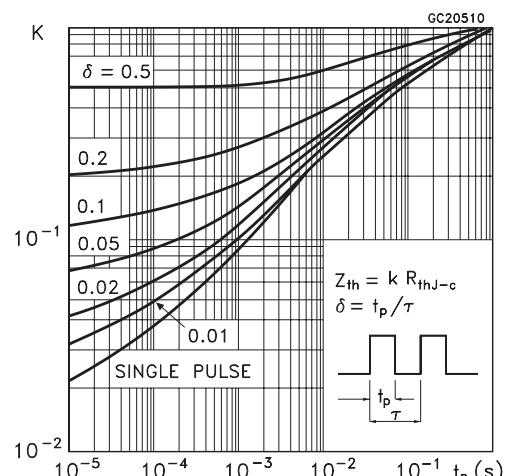


Figure 5. Output Characteristics

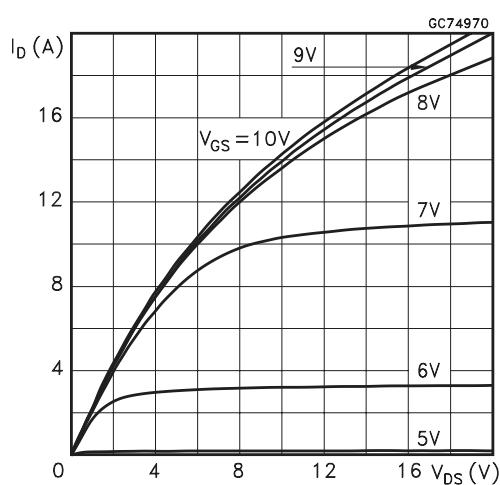


Figure 6. Transfer Characteristics

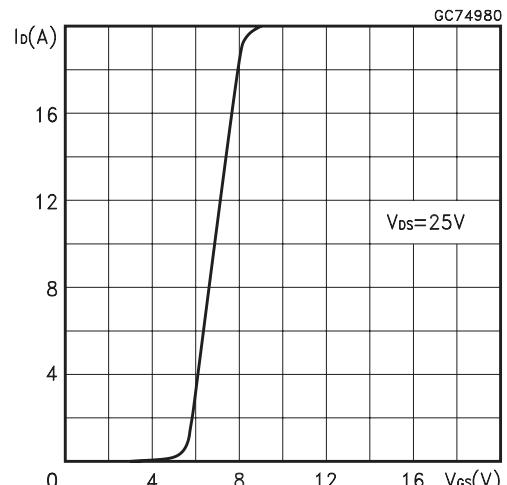


Figure 7. Transconductance

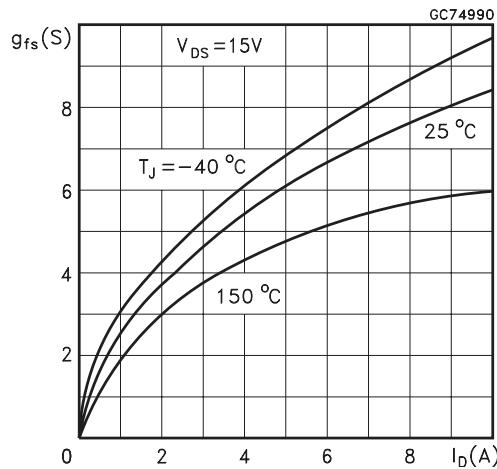


Figure 8. Static Drain-source On Resistance

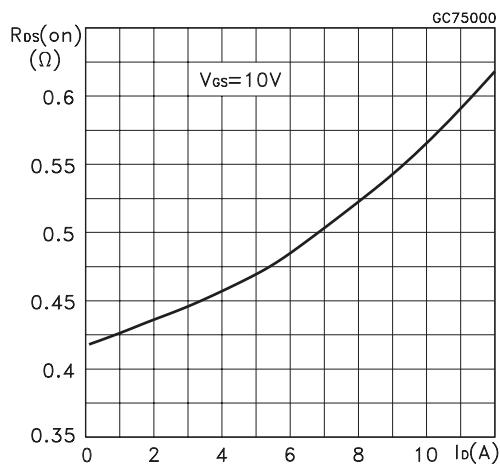


Figure 9. Gate Charge vs Gate-source Voltage

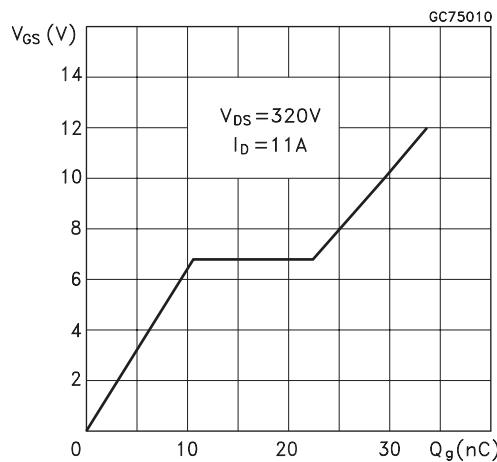


Figure 10. Capacitance Variations

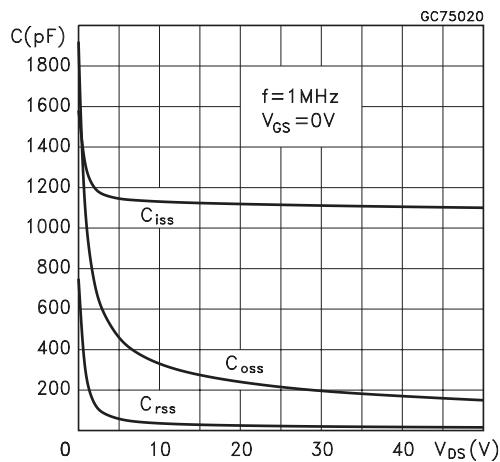


Figure 11. Normalized Gate Threshold Voltage vs Temperature

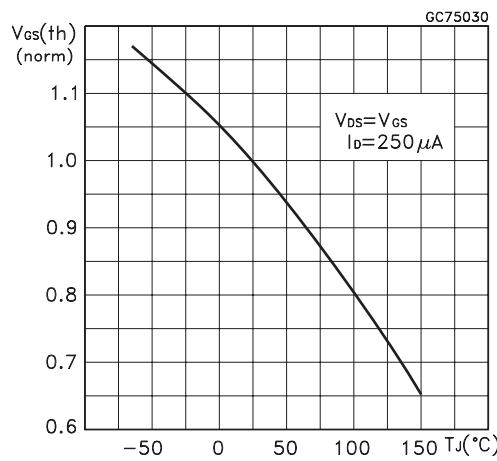
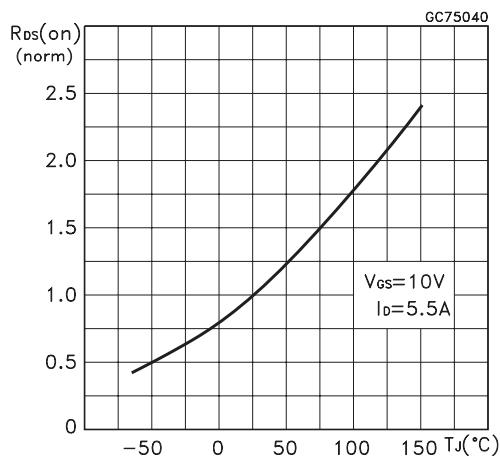


Figure 12. Normalized On Resistance vs Temperature



STB11NB40/STB11NB40-1

Figure 13. Source-drain Diode Forward Characteristics

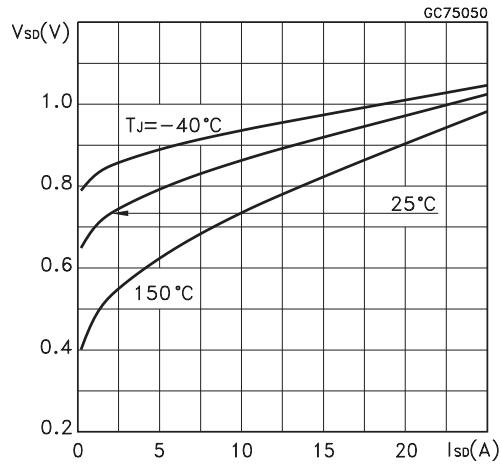


Figure 14. Unclamped Inductive Load Test Circuit

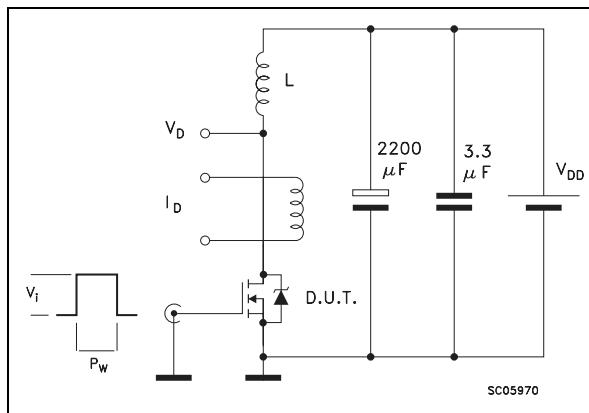


Figure 15. Unclamped Inductive Waveforms

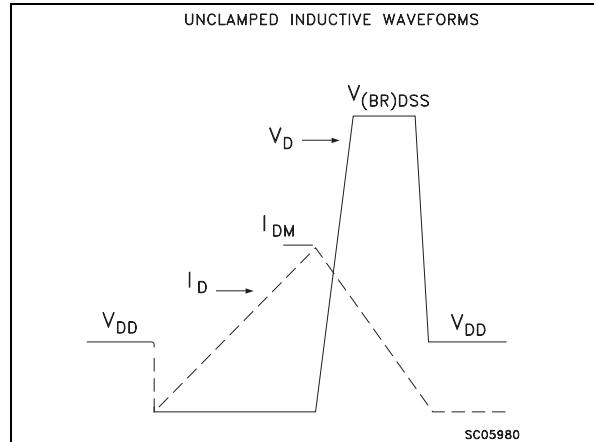


Figure 16. Switching Times Test Circuits For Resistive Load

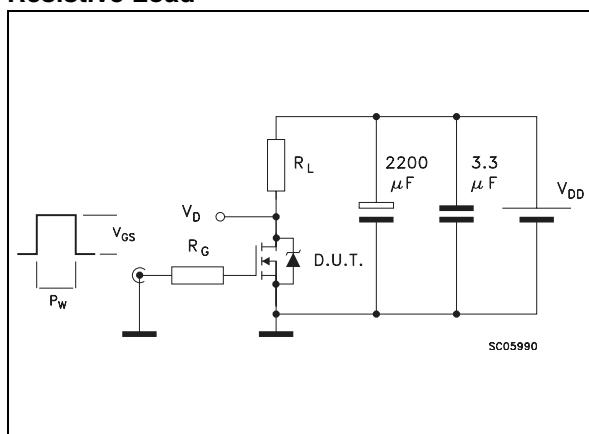


Figure 17. Gate Charge Test Circuit

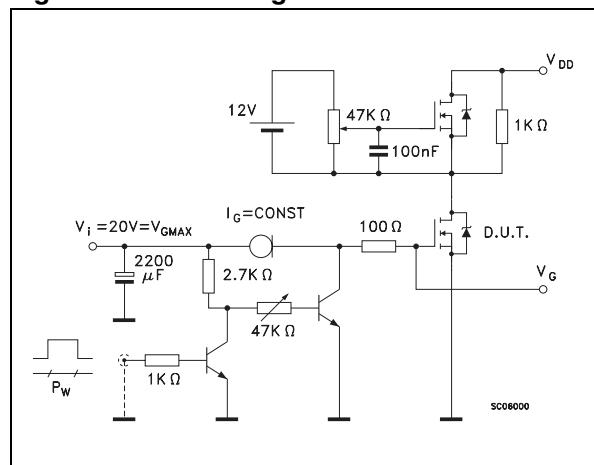
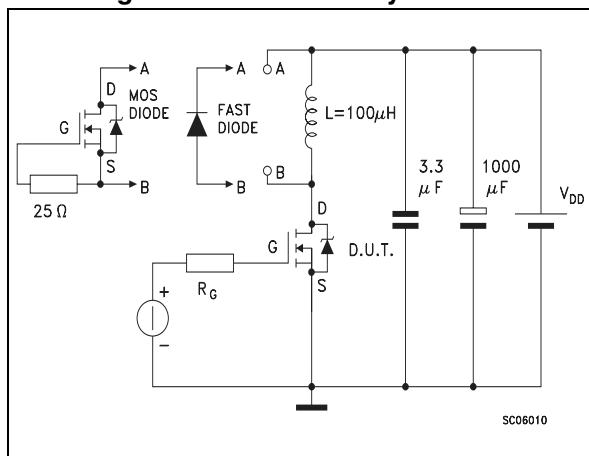


Figure 18. Test Circuit For Inductive Load Switching And Diode Recovery Times



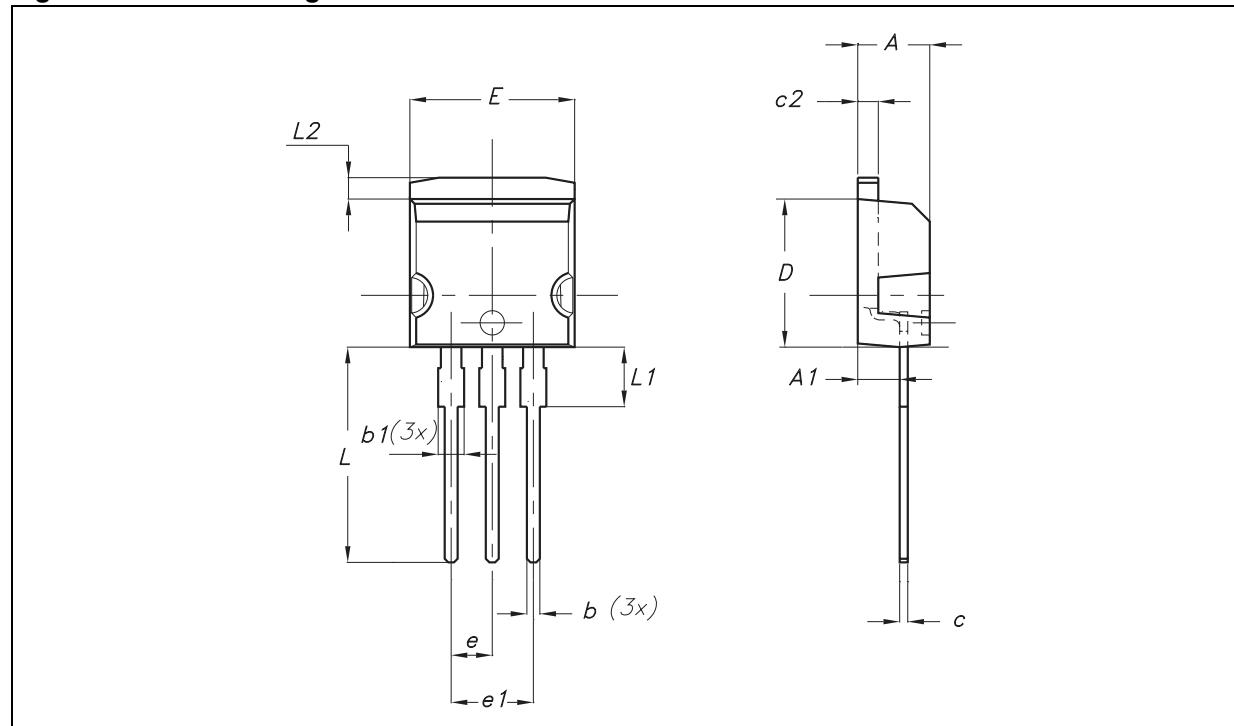
STB11NB40/STB11NB40-1

PACKAGE MECHANICAL

Table 12. I²PAK Mechanical Data

Symbol	millimeters			inches		
	Min	Typ	Max	Min	Typ	Max
A	4.40		4.60	0.173		0.181
A1	2.40		2.72	0.094		0.107
b	0.61		0.88	0.024		0.349
b1	1.14		1.70	0.045		0.067
c	0.49		0.70	0.019		0.027
c2	1.23		1.32	0.048		0.052
D	8.95		9.35	0.352		0.368
e	2.40		2.70	0.094		0.106
e1	4.95		5.15	0.195		0.203
E	10.00		10.40	0.394		0.409
L	13.00		14.00	0.511		0.551
L1	3.50		3.93	0.138		0.154
L2	1.27		1.40	0.050		0.055

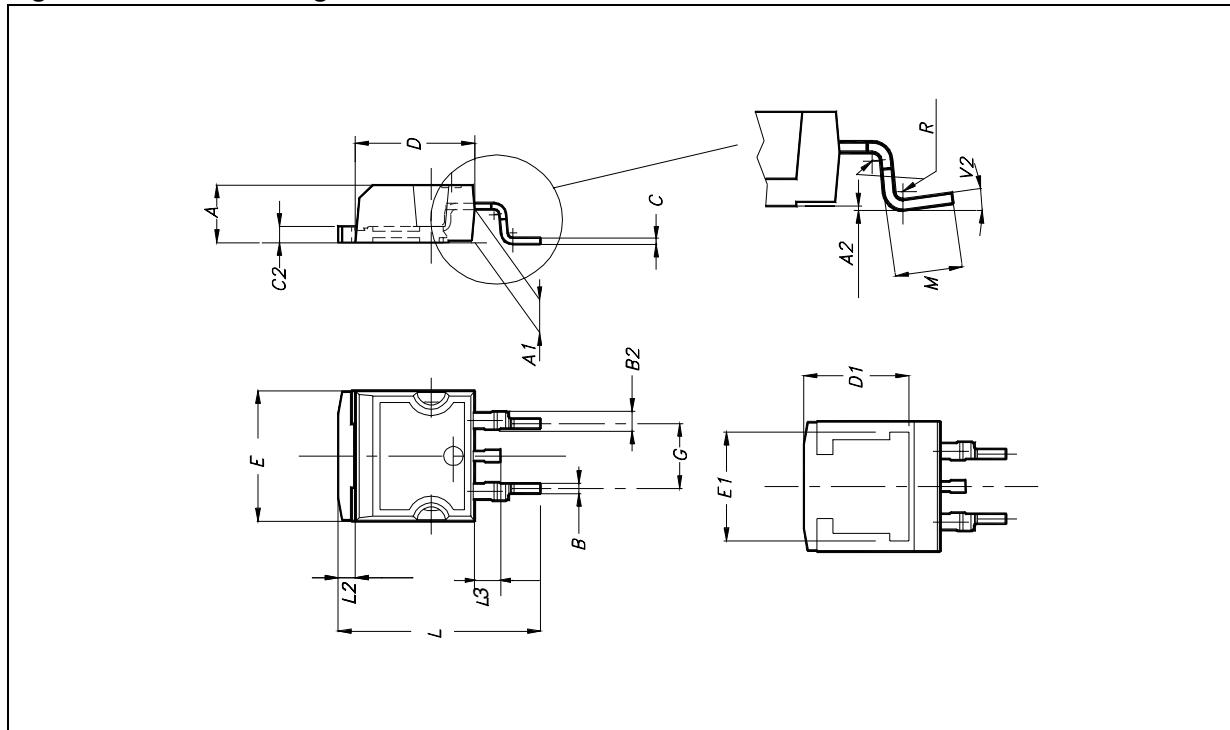
Figure 19. I²PAK Package Dimensions



Note: Drawing is not to scale.

Table 13. D²PAK Mechanical Data

Symbol	millimeters			inches		
	Min	Typ	Max	Min	Typ	Max
A	4.4		4.6	0.173		0.181
A1	2.49		2.69	0.098		0.106
A2	0.03		0.23	0.001		0.009
B	0.7		0.93	0.027		0.036
B2	1.14		1.7	0.044		0.067
C	0.45		0.6	0.017		0.023
C2	1.23		1.36	0.048		0.053
D	8.95		9.35	0.352		0.368
D1		8			0.315	
E	10		10.4	0.393		
E1		8.5			0.334	
G	4.88		5.28	0.192		0.208
L	15		15.85	0.590		0.625
L2	1.27		1.4	0.050		0.055
L3	1.4		1.75	0.055		0.068
M	2.4		3.2	0.094		0.126
R		0.4			0.015	
V2	0°		4°			

Figure 20. D²PAK Package Dimensions

Note: Drawing is not to scale.

STB11NB40/STB11NB40-1

REVISION HISTORY

Table 14. Revision History

Date	Revision	Description of Changes
March-1998	1	First Issue
14-Apr-2004	2	Stylesheet update. No content change.

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